

18. TEST PHOTOGRAPHS

See following Attached Pages for setup photographs.

FCC ID: A3LSMG955F	 PCTEST ENGINEERING LABORATORY, INC.	HAC (RF EMISSIONS) TEST REPORT			Approved by: Quality Manager
Filename: 1M1701030007-11-R1.A3L	Test Dates: 02/06/2017 - 02/08/2017	DUT Type: Portable Handset			Page 91 of 93

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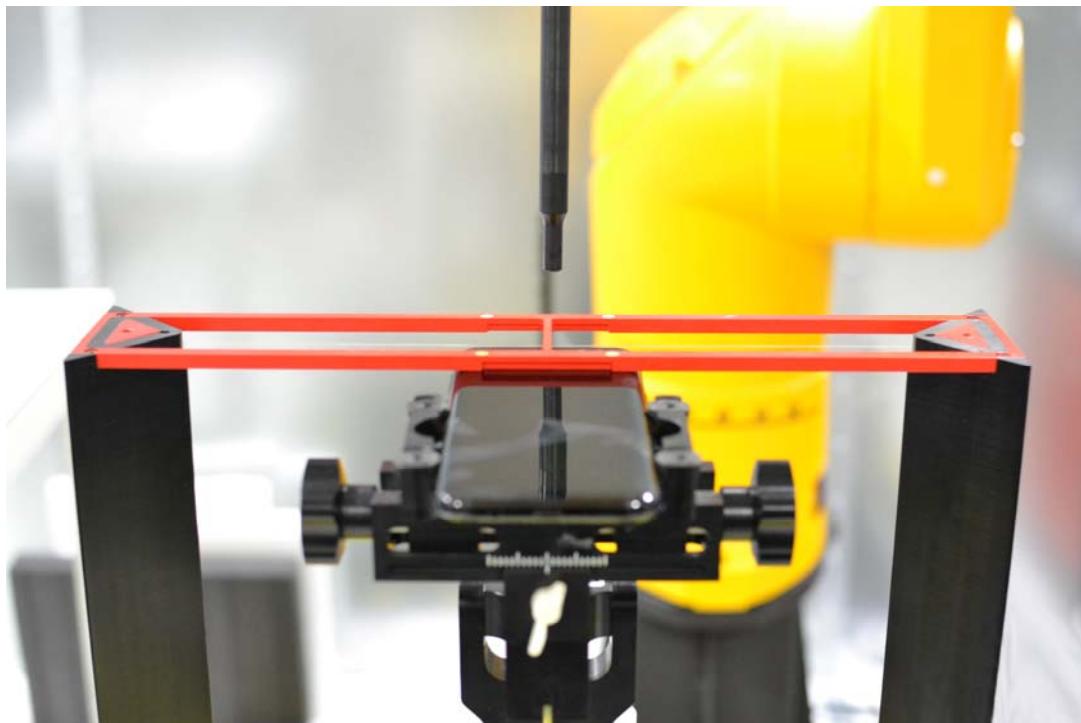


Figure 18-1
Ear Reference Point HAC Phantom Alignment

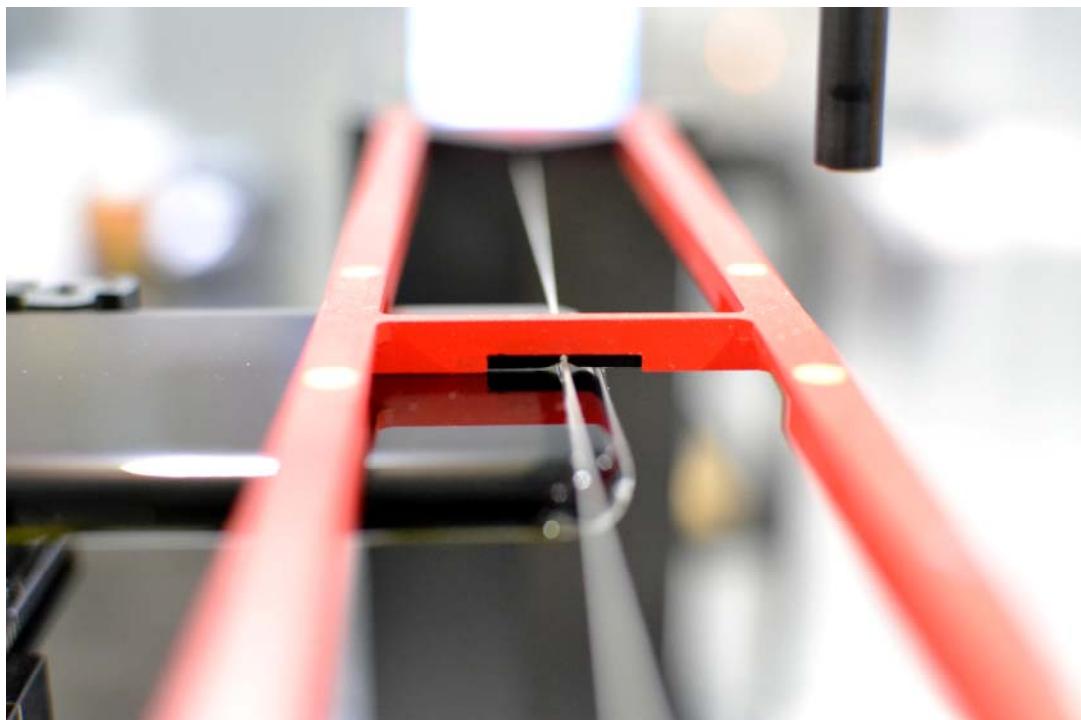


Figure 18-2
HAC Phantom Plane Alignment

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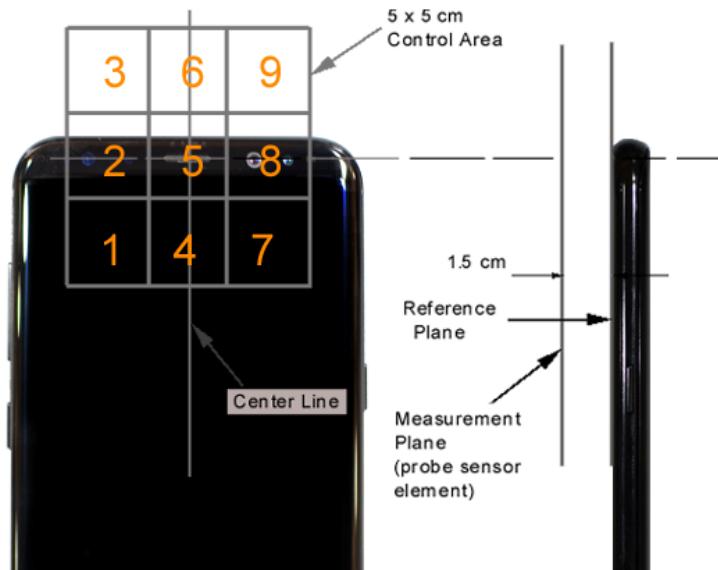


Figure 18-3 5x5 Scan grid above WD



Figure 18-4 E-Field WD Scan overlay

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